

# Device Modeling Report

COMPONENTS:THYRISTOR  
PART NUMBER:MCR218-2FP  
MANUFACTURER: MOTOROLA SEMICONDUCTOR



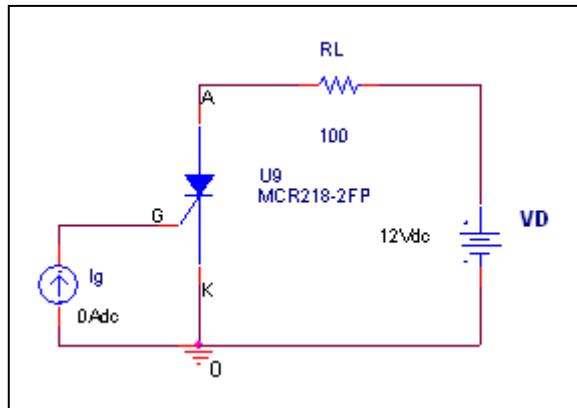
**Bee Technologies Inc.**

## DIODE MODEL

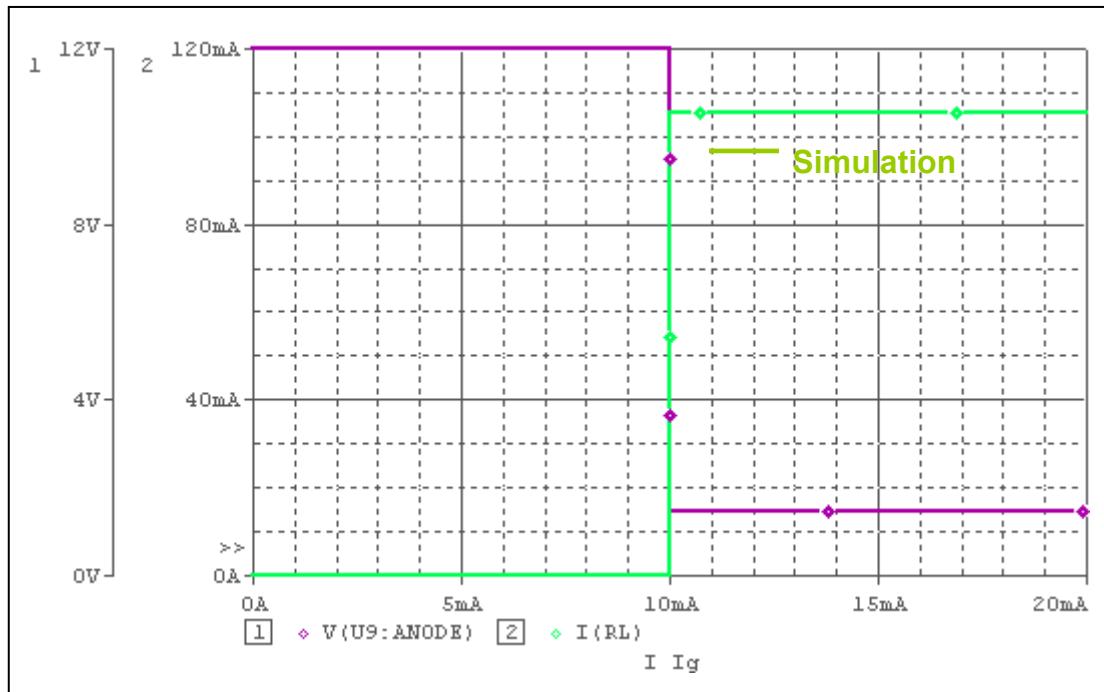
| Pspice model Parameter | Model description                           |
|------------------------|---|
| IS                     | Saturation Current                          |
| N                      | Emission Coefficient                        |
| RS                     | Series Resistance                           |
| IKF                    | High-injection Knee Current                 |
| CJO                    | Zero-bias Junction Capacitance              |
| M                      | Junction Grading Coefficient                |
| VJ                     | Junction Potential                          |
| ISR                    | Recombination Current Saturation Value      |
| BV                     | Reverse Breakdown Voltage(a positive value) |
| IBV                    | Reverse Breakdown Current(a positive value) |
| TT                     | Transit Time                                |

## IG-VT Characteristic

Evaluation Circuit



Simulation result

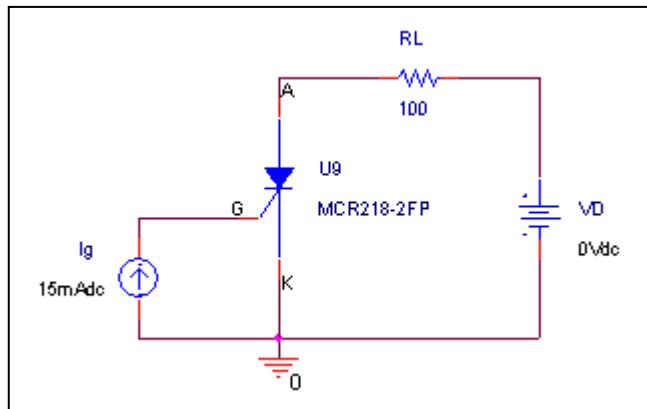


Comparison Table

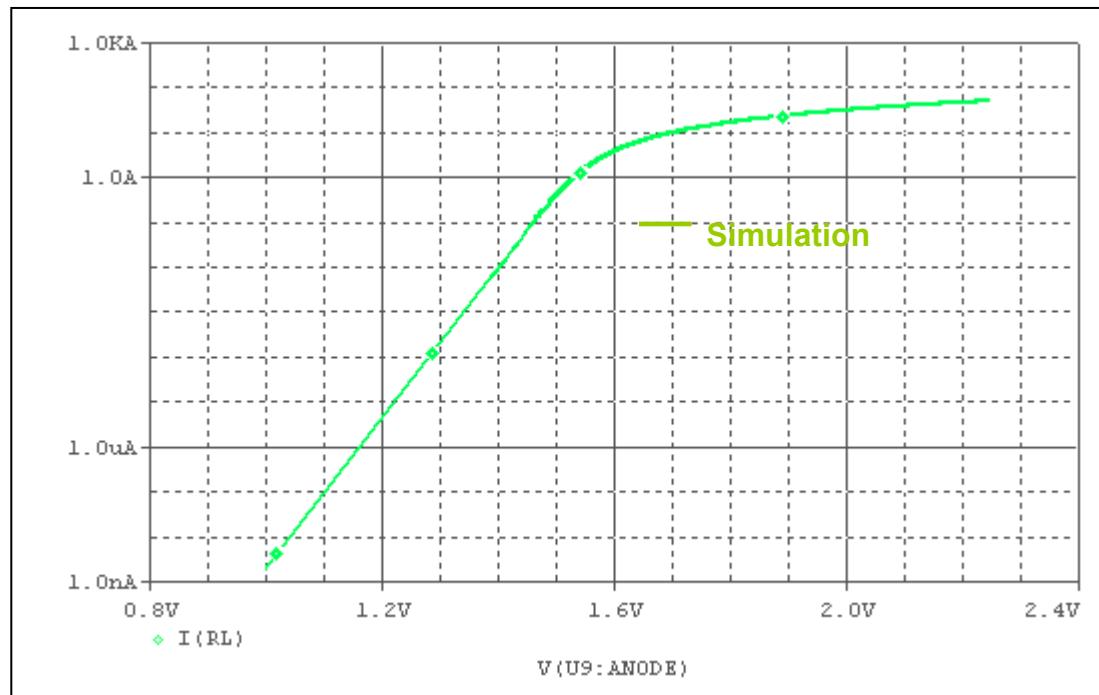
|                      | Measurement | Simulation | % Error  |
|----------------------|-------------|------------|----------|
| IG <sub>T</sub> (mA) | 10          | 10.005     | 0.05000  |
| V <sub>GT</sub> (V)  | 1.5(max)    | 1.4630     | -2.46667 |

## ITM-VTM Characteristic

Evaluation Circuit



Simulation result

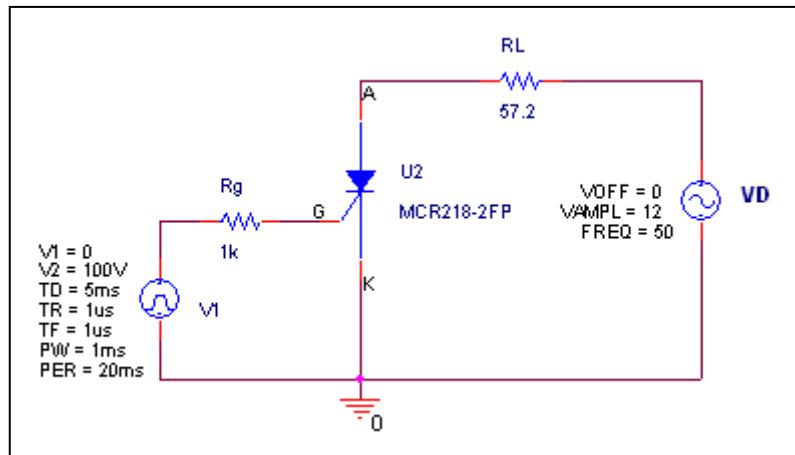


Comparison Table

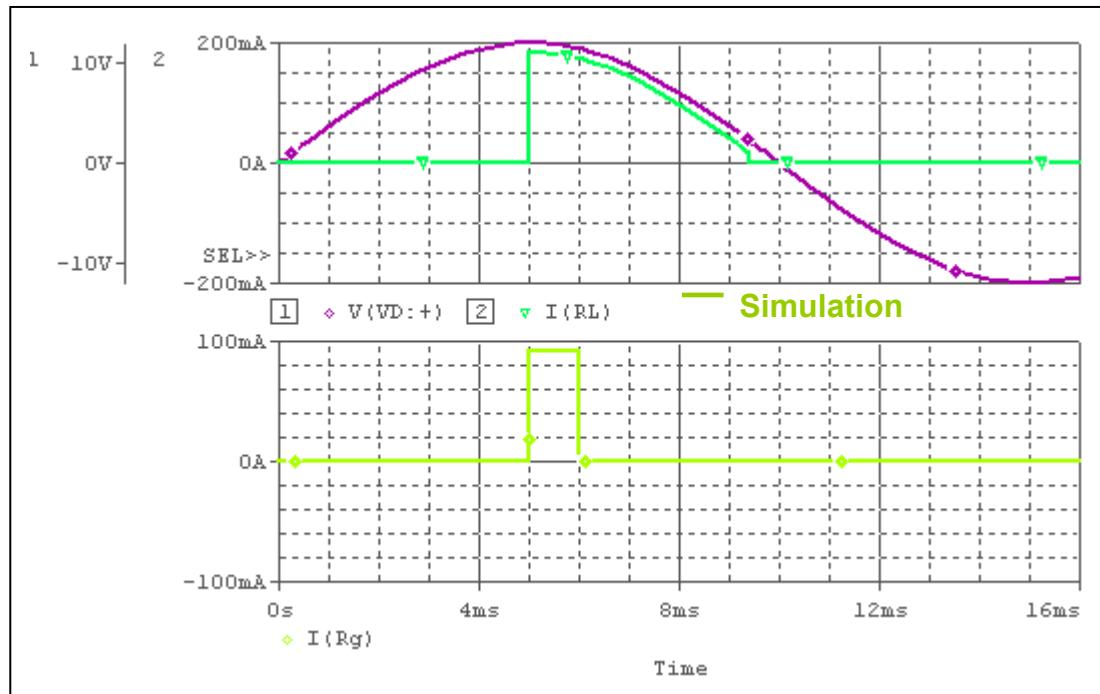
| At ITM=16A | Measurement | Simulation | % Error  |
|------------|-------------|------------|----------|
| VTM(V)     | 1.8(max)    | 1.7911     | -0.49444 |

## Holding Characteristic (IH)

Evaluation Circuit



Simulation result

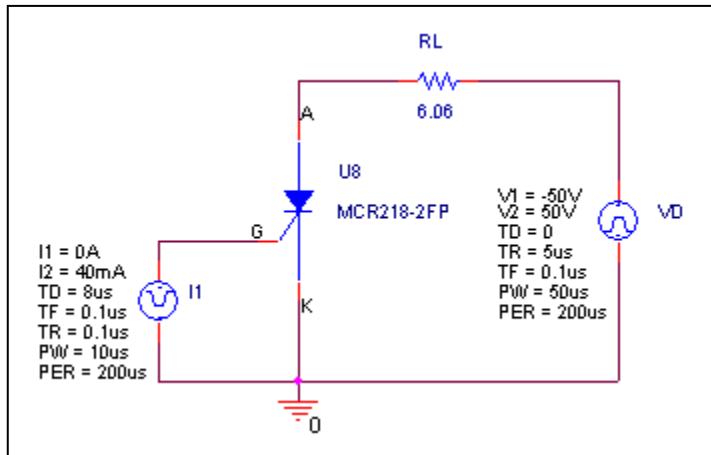


Comparison Table

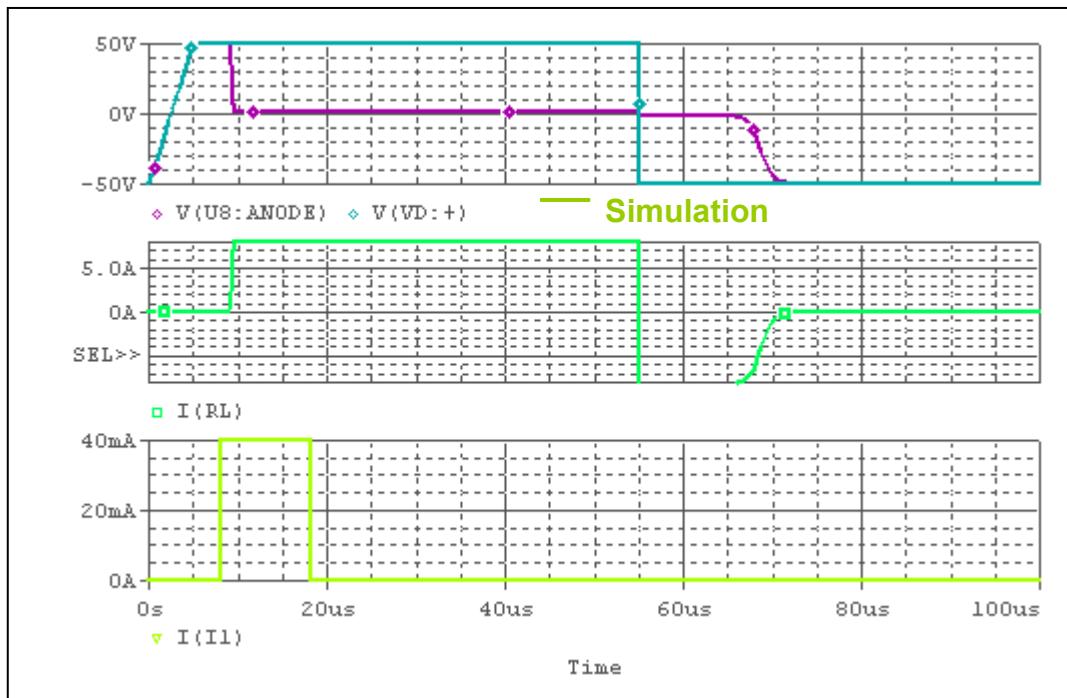
| VD=12V | Measurement | Simulation | % Error  |
|--------|-------------|------------|----------|
| IH(mA) | 16          | 15.878     | -0.76250 |

## Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

|          | Measurement | Simulation | %Error   |
|----------|-------------|------------|----------|
| Ton(us)  | 1.5         | 1.4981     | -0.12667 |
| Toff(us) | 15          | 15.131     | 0.87333  |